



Q.raxx is the ideal 19" rackmount DAQ solution for applications that require high channel density and custom sensor terminations. Q.raxx DAQ systems can utilize an integrated, high-performance controller for communication, control, and data logging purposes. With a controller, multiple Q.raxx systems can be synchronized to each other allowing for efficient DAQ distribution with low jitter and gradual expansion up to thousands of channels.

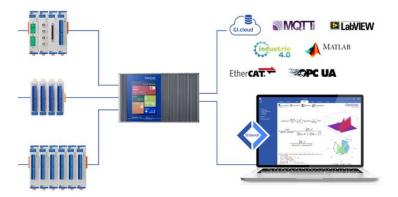
- High Density up to 13 I/O modules per Q.raxx 3U chassis with up to 16 channels per I/O module
- User Friendly front panel indicators for module status, power, and input range error
- Fully Customizable multiple front panel termination options available
- Maximum Flexibility parallel communication available in TCP/IP, CAN, PROFIBUS, Modbus, and EtherCAT



Key Features

- 8 Analog input channels differential voltage, current (with shunt resistor)
- 2 Digital inputs and outputs status, trigger, tare, alarm, command
- High-accuracy digitization24-bit ADC, 10 kHz sample rate per channel
- Signal conditioning
 linearization, filtering, average, scaling, min/max, RMS, arithmetic, alarm
- 3-Way galvanic isolation
 500 VDC channel to channel, channel to power supply, and bank
- Electromagnetic compatibility (EMC) according to IEC 61000-4 and EN 55011

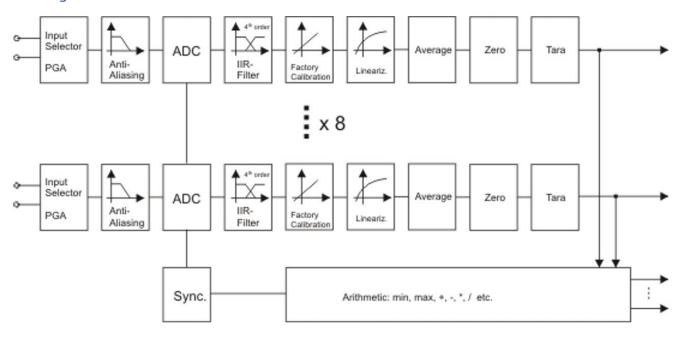






Voltage Measurement Module

Block diagram



Technical Data

Analog Input

Channels	8
Accuracy	0.01 % typical
	0.025 % in controlled environment ¹
	0.05 % in industrial area ²
Linearity error	0.01 % typical full-scale
Repeatability	0.003 % typical (within 24 hrs)
Input impedance	>1 MΩ
Common-mode voltage (cmv)	±500 VDC
Common-mode rejection ratio (cmrr)	>100 dB at 50 or 60 Hz
Isolation voltage	500 VDC channel to channel, channel to power supply, and channel to bus ³

 $^{^{\}mathrm{1}}$ according to EN 61326 2006: appendix B

² according to EN 61326 2006: appendix A

 $^{^{\}rm 3}\,$ noise pulses up to 1000 VDC, permanent up to 250 VDC



Voltage Measurement Module

Analog to Digital Conversion

Resolution	24-bit
Update rate	10 kHz per channel
Modulation method	sigma-delta (group delay time 600 μs)
Anti-aliasing filter	2 kHz, 3rd order
Digital filters	Infinite Impulse Response (IIR), low-pass, high-pass, band-pass, band-stop, Butterworth or Bessel (2nd, 4th, 6th or 8th order), frequency range 0.1 Hz to 1 kHz
Averaging	configurable or automatic according to the user-defined data rate

Measurement Mode Voltage

Input range	±10 VDC	
Margin of error	±2 mV	
Resolution	1.5 μV	
Long-term stability	<25 µV / 24 hrs	<100 µV / 8000 hrs
Temperature drift	<50 µV / 10 K offset drift	<100 ppm / 10 K gain drift
Signal-to-noise ratio	>100 dB at 100 Hz	>120 dB at 1 Hz

Digital Input

Channels	2
Mode(s) of operation	status
Logic voltage	<2 VDC (Low) >10 VDC (High)
Input type	PNP (current sinking)
Input voltage	30 VDC max.
Input current	2 mA max.
Isolation voltage	500 VDC, group to group, group to power supply, channel to bus ¹

 $^{^{\}rm 1}\,$ noise pulses up to 1000 VDC, permanent up to 250 VDC

Digital Output

Channels	2
Mode(s) of operation	status
Output voltage	10 - 30 VDC (external supply required)
Contact	open drain p-channel MOSFET
Load capacity	30 VDC / 100 mA (ohmic load)

Communication Interface

Electrical standard	RS-485, 2-wire
Data format	8E1
Protocols	local bus (115200 bps to 24 Mbps)
	ASCII (19200 bps to 115200 bps)
	Modbus RTU



Voltage Measurement Module

Power Supply

Input voltage	10 - 30 VDC, overvoltage and overcurrent protection
Power consumption	2 W (approx.)
Input voltage influence	<0.001 % / V

Environmental

Operating temperature	-20°C to +60°C
Storage temperature	-40°C to +85°C
Relative humidity	5 - 95 % at 50°C (non-condensing)

Remarks

Validity of all listed specifications are subject to a warm-up period of at least 45 minutes

Specifications subject to change without notice

Ordering Information

Article number	101923
Accessories	Terminal SR, article number 791989

